

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/718,543	FUJII ET AL.	
Examiner		Art Unit		Page 1 of 1
George D. Spisich		3616		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,244,601	01-1981	Nilsson, Thomas	280/805
*	B	US-5,873,599	02-1999	Bauer et al.	280/806
*	C	US-4,531,762	07-1985	Sasaki et al.	280/801.1
*	D	US-4,451,060	05-1984	Sylven, Hans	280/801.1
*	E	US-4,475,746	10-1984	Akiyama, Yoshinori	280/808
*	F	US-4,676,555	06-1987	Tokugawa, Osamu	297/473
*	G	US-4,729,602	03-1988	Tokugawa, Osamu	297/468
*	H	US-2003/0178835	09-2003	Nishimoto et al.	280/801.2
*	I	US-2002/0167158	11-2002	Enomoto et al.	280/804
*	J	US-6,698,795	03-2004	Enomoto et al.	280/808
*	K	US-5,294,184	03-1994	Blake et al.	297/473
*	L	US-4,915,414	04-1990	Weman, Per-Olof	280/801.1
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP03-118255	05-1991	Japan		
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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